

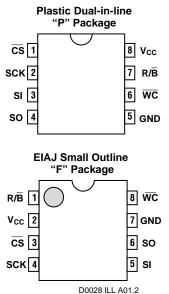
# 2,048-Bit Serial Electrically Erasable PROM Synchronous Peripheral Interface 2.7 to 5.5 Volt Operation

# FEATURES

- Motorola SPI (Modes 0 and 3) and SIOP Compatible
- 1 MHz Clock Rate
- Extended Temperature Range: -40°C to +85°C
- Low Power Consumption
  - Active current 500μA
     Standby current 2μA
- 2.7 to 5.5 volt operation (both READ and WRITE)
- Hardware & Software Write Protection
  - Defaults to disabled state at power up
     Software instructions for WRITE-enable/ disable
- Internally Organized as 128 x 16 bits
- Easy-to-Use Interface

   READY/BUSY status signal
   Automatic write cycle time-out
- High Reliability
  - Endurance: 100,000 erase/write cycles
  - Data retention: 100 years
- 8-Pin PDIP or SOIC Packages

# **PIN CONFIGURATIONS**



### PIN NAMES

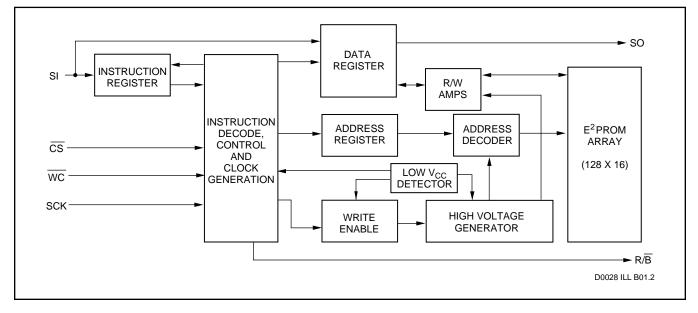
CS	Chip Select Input
SCK	Serial Clock Input
SI	Serial Input
SO	Serial Output
GND	Ground
WC	Write Control Input
R/B	READY/BUSY Output
Vcc	Power Supply

# OVERVIEW

The XL25026, a member of the SPI Lite<sup>™</sup> memory family, is a cost effective 2,048-bit, nonvolatile, serial E<sup>2</sup>PROM designed to directly interface with the Motorola SIOP and SPI ports. The XL25026 provides external read/write memory arranged as 128 registers of 16 bits each. Four 8-bit instructions control the operation of the device, which include read, write, write enable and write disable. The READY/BUSY pin indicates the status of the device when polled during the WRITE operation. The serial data output pin (SO) also indicates the status of the device during the self-timed nonvolatile programming cycle. To protect against inadvertent writes, the WRITE instruction is accepted only while the chip is in the write enabled state. After the initiation of the write cycle, if Chip Select ( $\overline{CS}$ ) is brought LOW, while SCK is low, the SO pin will indicate the READY/BUSY status of the chip.



# **BLOCK DIAGRAM**



#### ENDURANCE AND DATA RETENTION

The XL25026 is designed for applications requiring up to 100,000 erase/write cycles. It provides 100 years of secure data retention, with or without power applied.

# **DEVICE OPERATION**

The XL25026 is a synchronous serial port compatible  $E^2$ PROM. It operates on a single power supply ranging from 2.7V to 5.5V and it has an on-chip voltage generator to provide the high voltage needed during a programming operation. Input data is latched on the rising edge of the clock (SCK), and data is output on the falling edge of the clock.

Data is grouped in 8-bit bytes. The beginning 8 bits specify the mode, the next 8 bits specify the address, and subsequent 16 bits specify the I/O data. Each instruction sent to the device includes a 4 bit start sequence, 1010, a 4 bit opcode and a 7-bit address including one dummy bit at the end. For a WRITE operation, a 16 bit data field is required following the 8 bit address field. The device requires an active LOW  $\overline{CS}$  in order to be selected. Each instruction must be preceded by a HIGH-to-LOW transition of  $\overline{CS}$ before the 4 bit start sequence is given. Prior to the 4 bit start sequence (1010), inputs of all other logical sequence are ignored. During the self-timed internal programming cycle that accompanies a write, the SCK clock is deactivated. It is needed only when instructions or data are being passed to or from the memory.

Any of the four modes (read, write, write enable, write disable) may be specified. The write time is set by an internal timer, and determination of whether a write operation is in progress or not can be made from the status of the READY/BUSY pin.

#### Read (READ)

The read instruction is the only instruction that outputs serial data on the SO pin. After the read instruction and address have been decoded, data is transferred from the selected memory register into the output register. The output on SO changes during the HIGH to LOW transition of SCK.

#### Write (WRITE)

After a write instruction and its address have been decoded, the device expects 16 bits of data. These are to be transferred into the specific memory register which has previously been automatically erased. After the last data bit has been clocked into SI on the 32nd clock edge, the self-timed internal programming cycle is initiated. The write cycle status can be monitored by observing the READY/BUSY pin. It will output the BUSY status (LOW) within 1µs after the rising edge of the 32nd clock (the last





data bit) and will stay LOW until the WRITE cycle is complete. It will then output a HIGH status until the next WRITE cycle is initiated.  $\overline{CS}$  must be held HIGH for the minimum of t<sub>CS</sub> before the next instruction is entered.

Another way to get READY/BUSY status is from the SO pin. During a WRITE cycle, asserting a LOW on the  $\overline{CS}$  pin will cause the SO pin to output the READY/BUSY status. It is necessary for SCK to be brought into a LOW state 500ns prior to  $\overline{CS}$  going LOW. Asserting a HIGH on  $\overline{CS}$  will put the SO pin in a high impedance state again. After the WRITE cycle is completed, the SO pin will output HIGH when the device is deselected. The first rising edge of the SI pin will reset SO back into the high impedance state.

### Write Control (WC PIN)

The  $\overline{WC}$  pin provides hardware write control. When  $\overline{WC}$  pin is low, the chip is enabled to execute WRITE functions. When  $\overline{WC}$  pin is high, all WRITE functions are locked out. The device shows ready status on the R/B pin and on the SO pin, if  $\overline{CS}$  and SCK are low. In addition, if  $\overline{WC}$  pin changes state during the write cycle, the write operation will be aborted not guaranteeing the data. The  $\overline{WC}$  pin does not have any effect on the READ, WREN and WRDI operations.

#### Write Enable/Disable

When the XL25026 is powered up, it comes up in the write disabled state. In order to be programmable, it must receive an enable instruction. The device remains programmable until a disable instruction is entered, or until it is powered down. The disable instruction provides protection against inadvertent writes. Read operation is not affected by this command.

Instruction	Start Bits	OP Code	Address Data	Input
READ	1010	1000	(A6-A0) 0	
WRITE	1010	0100	(A6-A0) 0	D15-D0
Write Enable (WREN)	1010	0011	XXXXXXXX	
Write Disable (WRDI)	1010	0000	XXXXXXXX	

#### **INSTRUCTION SET**

D0028 PGM T01.4



# **ABSOLUTE MAXIMUM RATINGS**

Temperature under bias	40°C to +85°C
Storage Temperature.	65°C to +150°C
Lead Soldering Temperature (less than 10 seconds)	
Supply Voltage	
Voltage on Any Pin	0.3 to Vcc +0.3V
ESD Rating	
NOTE: These are STRESS ratings only. Appropriate conditions for operating these devices are given els	sewhere in this specification. Stresses
beyond those listed here may permanently damage the part. Prolonged exposure to maximum ratings may	ay affect device reliability.

# DC ELECTRICAL CHARACTERISTICS

 $T_A$  = -40°C to +85°C,  $V_{CC}$  = 2.7 to 5.5 Volts

0	Parameter	Conditions	V <sub>CC</sub> = 3.0V±10%		V <sub>CC</sub> = 5.0V±10%		11-16-				
Symbol			Min.	Max.	Min.	Max.	Units				
I <sub>CC1</sub>	Operating Current – CMOS	$\overline{CS} = V_{CC}$ , SCK = 1MHz		0.5		1	mA				
I <sub>CC2</sub>	Operating Current – TTL	<del>CS</del> = V <sub>IH</sub> , SCK = 1MHz		1.5		3	mA				
I <sub>SB</sub>	Standby Current	$\overline{\text{CS}}$ = DI = SCK = 0V		2		3	μA				
ILI	Input Leakage Current	$V_{IN} = 0V$ to $V_{CC}$ ( $\overline{CS}$ , SCK, SI)		1		1	μΑ				
I <sub>LO</sub>	Output Leakage Current	$V_{OUT} = 0V$ to $V_{CC}$ , $\overline{CS} = 0V$		1		1	μΑ				
V <sub>IL1</sub>	Input Low Voltage	SI Pin		0.3xV <sub>CC</sub>		$0.3 \mathrm{xV}_{\mathrm{CC}}$	V				
V <sub>IH1</sub>	Input High Voltage	SI Pin	0.7xV <sub>CC</sub>		0.7xV <sub>CC</sub>		V				
V <sub>IL2</sub>	Input Low Voltage	CS, SCK, WC Pin		0.2xV <sub>CC</sub>		0.2xV <sub>CC</sub>	V				
V <sub>IH2</sub>	Input High Voltage	CS, SCK, WC Pin	0.8xV <sub>CC</sub>		$0.8 \mathrm{xV}_{\mathrm{CC}}$		V				
V <sub>OL1</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1 mA TTL			0	0.4	V				
V <sub>OH1</sub>	Output High Voltage	I <sub>OH</sub> = -400 µA TTL			2.4	Vcc	V				
V <sub>OL2</sub>	Output Low Voltage	I <sub>OL</sub> = 10 μA CMOS		0.2		0.2	V				
V <sub>OH2</sub>	Output High Voltage	I <sub>OH</sub> = -10 μA CMOS	V <sub>CC</sub> -0.2		V <sub>CC</sub> -0.2		V				
		l		1	1	D002	D0028 PGM T02.2				

# **AC ELECTRICAL CHARACTERISTICS**

 $T_A = -40^{\circ}C$  to  $+85^{\circ}C$ ,  $V_{CC} = 2.7$  to 5.5 Volts

Symbol	Parameter	Conditions	V <sub>CC</sub> = 3.0	V <sub>CC</sub> = 3.0V±10%		V <sub>CC</sub> = 5.0V±10%	
Symbol		Conditions	Min.	Max.	Min.	Max.	Units
f <sub>SCK</sub>	SCK Clock Frequency			1		1	MHz
t <sub>WH</sub>	SCK HIGH Time		450		450		ns
t <sub>WL</sub>	SCK LOW Time		450		450		ns
t <sub>CS</sub>	Minimum CS HIGH Time		1000		1000		ns
t <sub>CSS</sub>	CS Setup Time	Relative to SCK	200		200		ns
t <sub>SU</sub>	SI Setup Time	Relative to SCK	150		150		ns
t <sub>CSH</sub>	CS Hold Time	Relative to SCK	0		0		ns
t <sub>H</sub>	SI Hold Time	Relative to SCK	150		150		ns
t <sub>PD1</sub>	Output Delay to "1"	AC Test		350		350	ns
t <sub>PD0</sub>	Output Delay to "0"	AC Test		350		350	ns
t <sub>SV</sub>	CS to Status Valid	AC Test		1000		1000	ns
t <sub>OH</sub>	CS to SO in 3-state	CS Hi to SO Hi-z	0	400	0	400	ns
t <sub>E/W</sub>	Write Cycle Time			15		10	ms
t <sub>WCS</sub>	Write Control Setup Time	Relative to CS	0		0		ns
t <sub>WCH</sub>	Write Control Hold Time	Relative to CS	0		0		ns

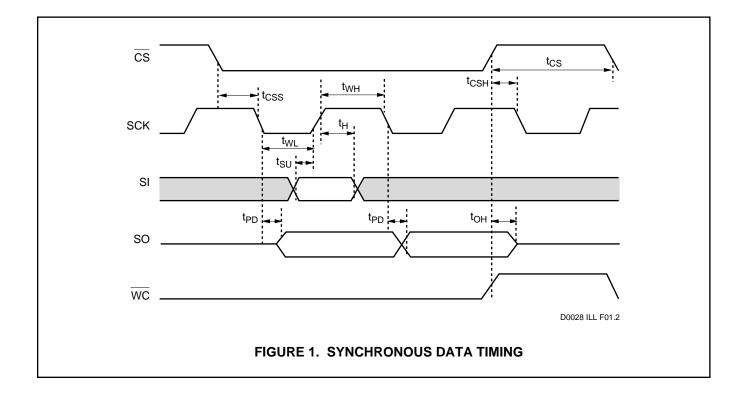


# CAPACITANCE

 $T_A = 25^{\circ}C$ , f = 1MHz

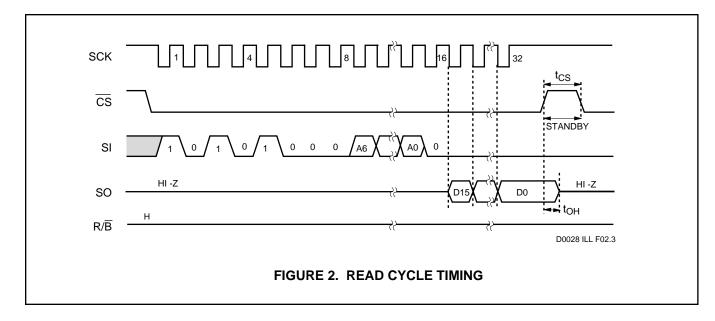
Symbol	Parameter	Parameter Max	
C <sub>IN</sub>	Input Capacitance	5	pF
Соит	Output Capacitance	5	pF

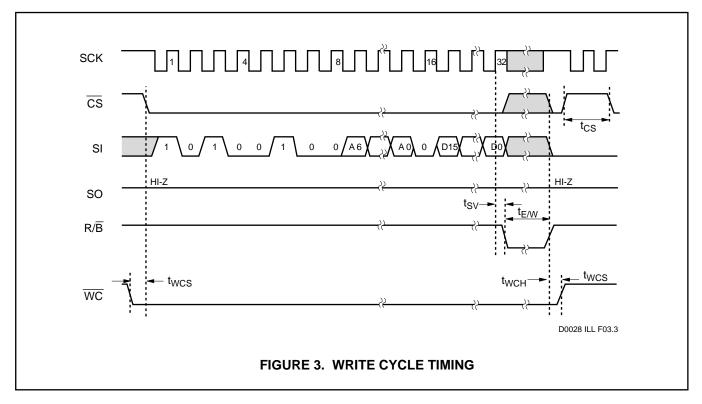
D0028 PGM T04.1



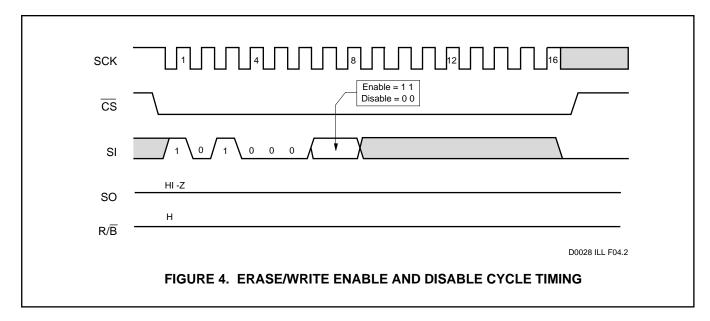


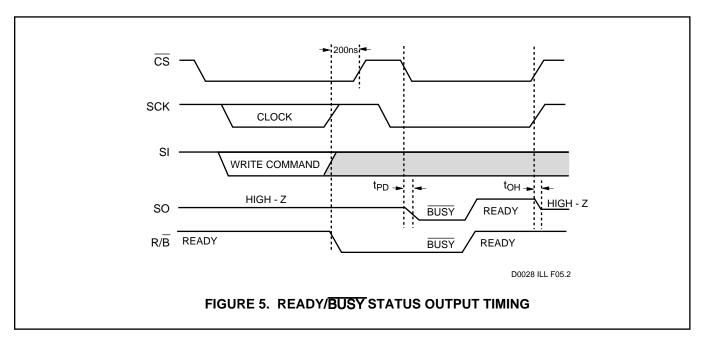








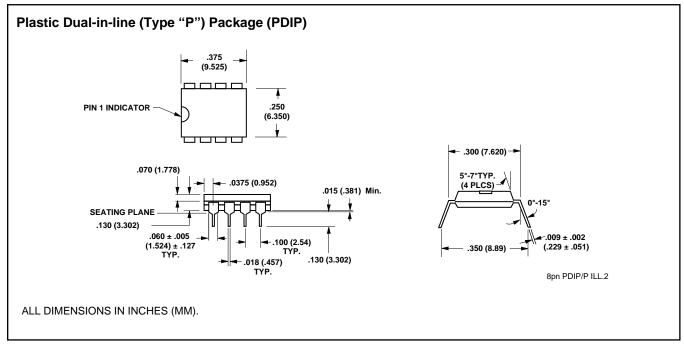


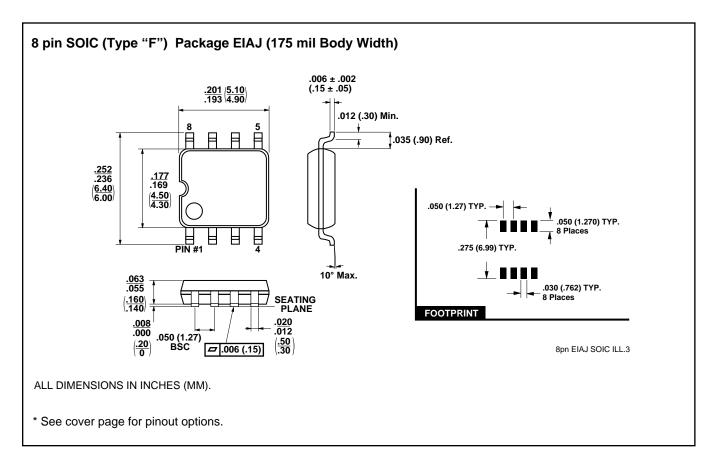






### PACKAGE DIAGRAMS









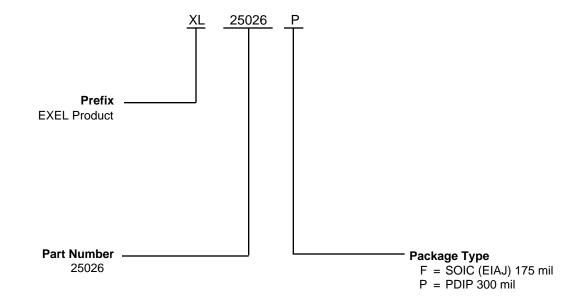
# ORDERING INFORMATION

**Standard Configurations** 

Prefix	Prefix Part Pa Type	
XL	25026	P, F

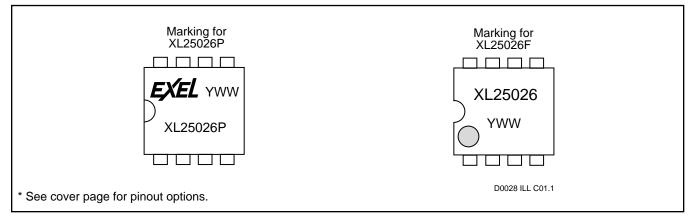
D0028 PGM TO5.1

Part Numbers:



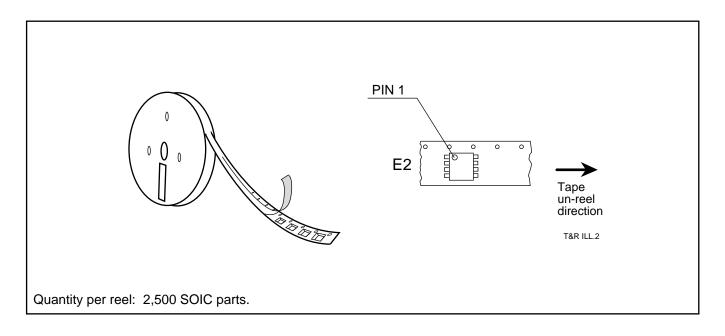


# MARKING INFORMATION



# TAPE AND REEL (EMBOSSED) INFORMATION

Surface mount devices, which are normally shipped in antistatic plastic tubes, are also available mounted on embossed tape for customers using automatic placement systems. The following diagram provides general information regarding the direction of the IC's. Tape "E2" shall be designated with PIN 1 at the trail direction.







NOTES:



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